

# FDW2509NZ

# Common Drain N-Channel 2.5V Specified PowerTrench® MOSFET

### **General Description**

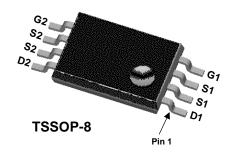
This N-Channel 2.5V specified MOSFET is a rugged gate version of Fairchild's Semiconductor's advanced PowerTrench process. It has been optimized for power management applications with a wide range of gate drive voltage (2.5V – 12V).

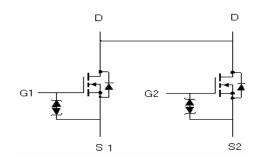
### **Applications**

Li-Ion Battery Pack

### **Features**

- 7.1 A, 20 V.  $R_{DS(ON)} = 20 \text{ m}\Omega$  @  $V_{GS} = 4.5 \text{ V}$  $R_{DS(ON)} = 26 \text{ m}\Omega$  @  $V_{GS} = 2.5 \text{ V}$
- Extended V<sub>GSS</sub> range (±12V) for battery applications
- ESD protection diode (note 3)
- High performance trench technology for extremely low R<sub>DS(ON)</sub>
- Low profile TSSOP-8 package





### Absolute Maximum Ratings TA=25°C unless otherwise noted

Symbol	Parameter		Ratings	Units
V <sub>DSS</sub>	Drain-Source Voltage		20	V
V <sub>GSS</sub>	Gate-Source Voltage		±12	
I <sub>D</sub>	Drain Current - Continuous	(Note 1a)	7.1	Α
	- Pulsed		30	
P <sub>D</sub>	Power Dissipation for Single Operation	(Note 1a)	1.6	W
		(Note 1b)	1.1	
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperat	ure Range	-55 to +150	°C

### **Thermal Characteristics**

$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1a)	77	°C/W
		(Note 1b)	114	

**Package Marking and Ordering Information** 

Device Marking	Device	Reel Size	Tape width	Quantity
2509NZ	FDW2509NZ	13"	12mm	3000 units

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Char	acteristics		II.	I		1
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, \qquad I_{D} = 250 \mu\text{A}$	20			V
<u>ΔBV<sub>DSS</sub></u> ΔT <sub>J</sub>	Breakdown Voltage Temperature Coefficient	$I_D$ = 250 $\mu$ A, Referenced to 25°C		11		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS} = 16 \text{ V},  V_{GS} = 0 \text{ V}$			1	μΑ
I <sub>GSS</sub>	Gate-Body Leakage	$V_{GS} = \pm 12 \text{ V},  V_{DS} = 0 \text{ V}$			± 10	μΑ
On Chara	acteristics (Note 2)					
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}$ , $I_D = 250 \mu A$	0.6	0.8	1.5	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	$I_D = 250 \mu A$ , Referenced to 25°C		-3		mV/°C
R <sub>DS(on)</sub>	Static Drain–Source On–Resistance	$\begin{array}{c} V_{GS} = 4.5 \; V,  I_D = 7.1 \; A \\ V_{GS} = 2.5 \; V,  I_D = 6.2 \; A \\ V_{GS} = 4.5 \; V, \; I_D = 7.1 A, \; T_J = 125 ^{\circ} C \end{array}$		15 18 20	20 26 29	mΩ
I <sub>D(on)</sub>	On-State Drain Current	$V_{GS} = 4.5 \text{ V},  V_{DS} = 5 \text{ V}$	15			Α
<b>g</b> <sub>FS</sub>	Forward Transconductance	$V_{DS} = 5 \text{ V}, \qquad I_{D} = 7.1 \text{ A}$		36		S
Dvnamic	Characteristics					
C <sub>iss</sub>	Input Capacitance	$V_{DS} = 10 \text{ V},  V_{GS} = 0 \text{ V},$		1263		pF
Coss	Output Capacitance	f = 1.0 MHz		327		pF
C <sub>rss</sub>	Reverse Transfer Capacitance	7		179		pF
$R_G$	Gate Resistance	$V_{GS} = 15 \text{ mV}, f = 1.0 \text{ MHz}$		1.9		Ω
Switchin	g Characteristics (Note 2)					
t <sub>d(on)</sub>	Turn-On Delay Time	$V_{DD} = 10 \text{ V},  I_{D} = 1 \text{ A},$		11	20	ns
t <sub>r</sub>	Turn-On Rise Time	$V_{GS} = 4.5 \text{ V},  R_{GEN} = 6 \Omega$		15	27	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	7		27	43	ns
t <sub>f</sub>	Turn-Off Fall Time	7		12	22	ns
$Q_g$	Total Gate Charge	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 7.1 A,		13	19	nC
Q <sub>gs</sub>	Gate-Source Charge	V <sub>GS</sub> = 4.5 V		2		nC
$Q_{gd}$	Gate-Drain Charge			4		nC
Drain-Sc	ource Diode Characteristics	and Maximum Ratings				
Is	Maximum Continuous Drain-Source	e Diode Forward Current			1.3	Α
$V_{SD}$	Drain–Source Diode Forward Voltage	$V_{GS} = 0 \text{ V}, \qquad I_{S} = 1.3 \text{ A}  \text{(Note 2)}$			1.2	V
t <sub>rr</sub>	Diode Reverse Recovery Time	$I_F = 7.1 \text{ A}, \qquad d_{iF}/d_t = 100 \text{ A/}\mu\text{s}$		20		nS
Q <sub>rr</sub>	Diode Reverse Recovery Charge	7		14		nC

#### Notes

- 1.  $R_{\theta,JA}$  is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins.  $R_{\theta,JC}$  is guaranteed by design while  $R_{\theta,CA}$  is determined by the user's board design.
  - a)  $\rm\,R_{\rm \theta JA}$  is 77°C/W (steady state) when mounted on a 1 inch² copper pad on FR-4.
  - b)  $\rm\,R_{\rm \thetaJA}$  is 114 °C/W (steady state) when mounted on a minimum copper pad on FR-4.
- 2. Pulse Test: Pulse Width < 300 $\mu$ s, Duty Cycle < 2.0%
- 3. The diode connected between the gate and source serves only as protection against ESD. No gate overvoltage rating is implied.

## **Typical Characteristics**

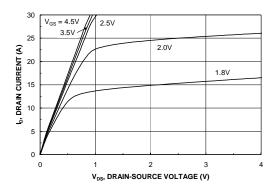


Figure 1. On-Region Characteristics.

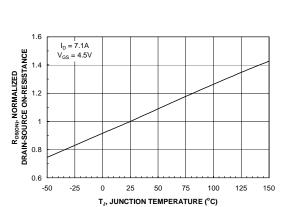


Figure 3. On-Resistance Variation with Temperature.

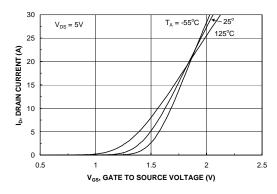


Figure 5. Transfer Characteristics.

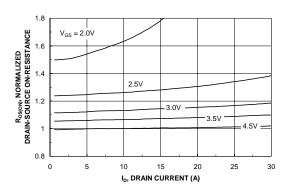


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

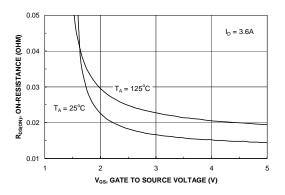


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

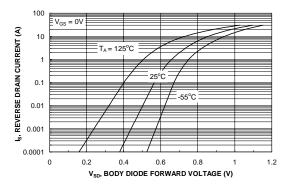
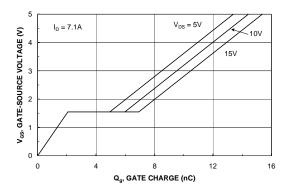


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

### **Typical Characteristics**



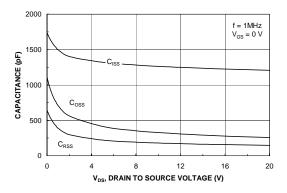


Figure 7. Gate Charge Characteristics.

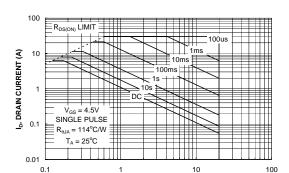


Figure 8. Capacitance Characteristics.

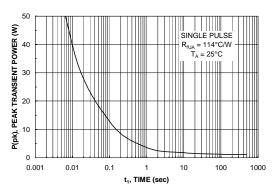


Figure 9. Maximum Safe Operating Area.

 $V_{DS}$ , DRAIN-SOURCE VOLTAGE (V)



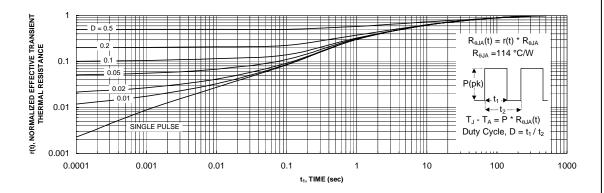


Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1b. Transient thermal response will change depending on the circuit board design.

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